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I.S. EN 61000-4-34:2007

Electromagnetic compatibility (EMC) --
Part 4-34: Testing and measurement
techniques - Voltage dips, short
interruptions and voltage variations
immunity tests for equipment with
input current more than 16 A per phase
(IEC 61000-4-34:2005 (EQV))

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Údarás um Chaighdeáin Náisiúnta na hÉireann

EUROPEAN STANDARD

EN 61000-4-34/A1

NORME EUROPÉENNE

EUROPÄISCHE NORM

August 2009

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English version

**Electromagnetic compatibility (EMC) -
Part 4-34: Testing and measurement techniques -
Voltage dips, short interruptions and voltage variations immunity tests
for equipment with mains current more than 16 A per phase
(IEC 61000-4-34:2005/A1:2009)**

Compatibilité électromagnétique (CEM) -
Partie 4-34: Techniques d'essai
et de mesure -
Essais d'immunité aux creux de tension,
coupures brèves et variations de tension
pour matériel ayant un courant
d'alimentation de plus de 16 A par phase
(CEI 61000-4-34:2005/A1:2009)

Elektromagnetische
Verträglichkeit (EMV) -
Teil 4-34: Prüf- und Messverfahren -
Prüfungen der Störfestigkeit
von Geräten und Einrichtungen
mit einem Netzstrom > 16 A je Leiter
gegen Spannungseinbrüche,
Kurzzeitunterbrechungen
und Spannungsschwankungen
(IEC 61000-4-34:2005/A1:2009)

This amendment A1 modifies the European Standard EN 61000-4-34:2007; it was approved by CENELEC on 2009-07-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this amendment the status of a national standard without any alteration.

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CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: Avenue Marnix 17, B - 1000 Brussels

Foreword

The text of document 77A/670/CDV, future amendment 1 to IEC 61000-4-34:2005, prepared by SC 77A, Low frequency phenomena, of IEC TC 77, Electromagnetic compatibility, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as amendment A1 to EN 61000-4-34:2007 on 2009-07-01.

The following dates were fixed:

- latest date by which the amendment has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2010-04-01
- latest date by which the national standards conflicting with the amendment have to be withdrawn (dow) 2012-07-01

Endorsement notice

The text of amendment 1:2009 to the International Standard IEC 61000-4-34:2005 was approved by CENELEC as an amendment to the European Standard without any modification.

EUROPEAN STANDARD

EN 61000-4-34

NORME EUROPÉENNE

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und Spannungsschwankungen
(IEC 61000-4-34:2005)

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CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

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- latest date by which the national standards conflicting with the EN have to be withdrawn (dow) 2010-04-01

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 61000-4-34:2005 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 61000-2-4	NOTE	Harmonized as EN 61000-2-4:2002 (not modified).
IEC 61000-4-11	NOTE	Harmonized as EN 61000-4-11:2004 (not modified).
IEC 61000-4-14	NOTE	Harmonized as EN 61000-4-14:1999 (not modified).

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60050-161	- ¹⁾	International Electrotechnical Vocabulary (IEV) - Chapter 161: Electromagnetic compatibility	-	-
IEC/TR 61000-2-8	- ¹⁾	Electromagnetic compatibility (EMC) - Part 2-8: Environment - Voltage dips and short interruptions on public electric power supply systems with statistical measurement results	-	-
IEC 61000-4-30	- ¹⁾	Electromagnetic compatibility (EMC) - Part 4-30: Testing and measurement techniques - Power quality measurement methods	EN 61000-4-30	2003 ²⁾

¹⁾ Undated reference.

²⁾ Valid edition at date of issue.

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROMAGNETIC COMPATIBILITY (EMC) –**Part 4-34: Testing and measurement techniques –
Voltage dips, short interruptions and voltage variations immunity tests
for equipment with mains current more than 16 A per phase**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as “IEC Publication(s)”). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 61000-4-34 has been prepared by subcommittee 77A: Low frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

It forms Part 4-34 of IEC 61000. It has the status of a Basic EMC Publication in accordance with IEC Guide 107.

This consolidated version of IEC 61000-4-34 consists of the first edition (2005) [documents 77A/498/FDIS and 77A/515/RVD], its amendment 1 (2009) [documents 77A/670/CDV and 77A/688/RVC] and its corrigendum 1 of November 2009.

The technical content is therefore identical to the base edition and its amendment and has been prepared for user convenience.

It bears the edition number 1.1.

A vertical line in the margin shows where the base publication has been modified by amendment 1.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of the base publication and its amendments will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

INTRODUCTION

IEC 61000 is published in separate parts according to the following structure:

Part 1: General

General considerations (introduction, fundamental principles)
Definitions, terminology

Part 2: Environment

Description of the environment
Classification of the environment
Compatibility levels

Part 3: Limits

Emission limits
Immunity limits (in so far as they do not fall under the responsibility of the product committees)

Part 4: Testing and measurement techniques

Measurement techniques
Testing techniques

Part 5: Installation and mitigation guidelines

Installation guidelines
Mitigation methods and devices

Part 6: Generic standards

Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as international standards or as technical specifications or technical reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and a second number identifying the subdivision (example: 61000-6-1).

ELECTROMAGNETIC COMPATIBILITY (EMC) –

Part 4-34: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests for equipment with mains current more than 16 A per phase

1 Scope

This part of IEC 61000 defines the immunity test methods and range of preferred test levels for electrical and electronic equipment connected to low-voltage power supply networks for voltage dips, short interruptions, and voltage variations.

This standard applies to electrical and electronic equipment having a rated mains current exceeding 16 A per phase. (See Annex E for guidance on electrical and electronic equipment rated at more than 200 A per phase.) It covers equipment installed in residential areas as well as industrial machinery, specifically voltage dips and short interruptions for equipment connected to either 50 Hz or 60 Hz a.c. networks, including 1-phase and 3-phase mains.

NOTE 1 Equipment with a rated mains current of 16 A or less per phase is covered by publication IEC 61000-4-11.

NOTE 2 There is no upper limit on rated mains current in this publication. However, in some countries, the rated mains current may be limited to some upper value, for example 75 A or 250 A, because of mandatory safety standards.

It does not apply to electrical and electronic equipment for connection to 400 Hz a.c. networks. Tests for equipment connected to these networks will be covered by future IEC standards.

The object of this standard is to establish a common reference for evaluating the immunity of electrical and electronic equipment when subjected to voltage dips, short interruptions and voltage variations.

NOTE 1 Voltage fluctuations are covered by publication IEC 61000-4-14.

NOTE 2 For equipment under test with rated currents above 250 A, suitable test equipment may be difficult to obtain. In these cases, the applicability of this standard should be carefully evaluated by committees responsible for generic, product and product-family standards. Alternatively, this standard might be used as a framework for an agreement on performance criteria between the manufacturer and the purchaser.

The test method documented in this part of IEC 61000 describes a consistent method to assess the immunity of equipment or a system against a defined phenomenon. As described in IEC Guide 107, this is a basic EMC publication for use by product committees of the IEC. As also stated in Guide 107, the IEC product committees are responsible for determining whether this immunity test standard should be applied or not, and if applied, they are responsible for defining the appropriate test levels. Technical committee 77 and its sub-committees are prepared to co-operate with product committees in the evaluation of the value of particular immunity tests for their products.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-161, *International Electrotechnical Vocabulary (IEV) – Chapter 161: Electromagnetic compatibility*

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